Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/734,422	CHANG ET AL.
Examiner	Art Unit

Daborah Chacko-Davis

1756

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
updated se	rference-see arch history t out	6/1/2007	DCD		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
(430/313,320; 360/324; 216/22;204/192.34) updated text search only-see updated search history print out	6/1/2007	DCD
EAST (US-PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM-TDB) See updated search history print out	6/1/2007	DCD
. Updated eDAN inventor search	6/1/2007	DCD
Updated search history print out	6/6/2007	DCD